TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSIII)

TPC8108

Lithium Ion Battery Applications Notebook PC Applications Portable Equipment Applications

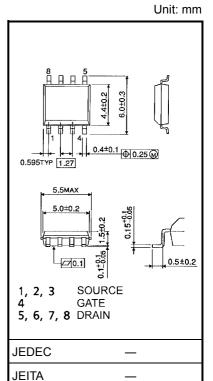
- Small footprint due to small and thin package
- Low drain-source ON resistance: $RDS(ON) = 9.5 \text{ m}\Omega \text{ (typ.)}$
- High forward transfer admittance: $|Y_{fs}| = 24 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -30 \text{ V)}$
- Enhancement-mode: $V_{th} = -0.8 \text{ to } -2.0 \text{ V (V}_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

| Characte | ristics | Symbol | Rating | Unit | |
|--|---------------------------------|------------------|------------|------|--|
| Drain-source voltage | | V_{DSS} | -30 | V | |
| Drain-gate voltage (F | $R_{GS} = 20 \text{ k}\Omega$) | V_{DGR} | -30 | V | |
| Gate-source voltage | | V_{GSS} | ±20 | V | |
| Drain current | DC (Note 1) | ΙD | -11 | Α | |
| Brain current | Pulse (Note 1) | I_{DP} | -44 | A | |
| Drain power dissipati | on $(t = 10 s)$ (Note 2a) | P_{D} | 1.9 | W | |
| Drain power dissipation $(t = 10 s)$ (Note 2b) | | P_{D} | 1.0 | W | |
| Single pulse avalanc | he energy (Note 3) | E _{AS} | 157 | mJ | |
| Avalanche current | | I _{AR} | -11 | Α | |
| Repetitive avalanche | energy Note 2a) (Note 4) | E _{AR} | 0.19 | mJ | |
| Channel temperature | | T _{ch} | 150 | °C | |
| Storage temperature range | | T _{stg} | -55 to 150 | °C | |

Note: For (Note 1), (Note 2), (Note 3) and (Note 4), please refer to the next page.

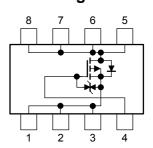
This transistor is an electrostatic sensitive device. Please handle with caution.



Weight: 0.080 g (typ.)

TOSHIBA

Circuit Configuration

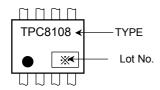


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Thermal Characteristics

| Characteristics | Symbol | Max | Unit |
|---|------------------------|------|------|
| Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a) | R _{th (ch-a)} | 65.8 | °C/W |
| Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2b) | R _{th (ch-a)} | 125 | °C/W |

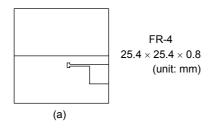
Marking (Note 5)

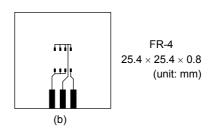


Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)





Note 3: $V_{DD} = -24~V,~T_{ch} = 25^{\circ}C$ (initial), L = 1.0 mH, R_G = 25 $\Omega,~I_{AR} = -11~A$

Note 4: Repetitive rating; pulse width limited by maximum channel temperature

Note 5: • on lower left of the marking indicates Pin 1.

Weekly code: (Three digits)
 Week of manufacture

 (01 for first week of year, continues up to 52 or 53)

 Year of manufacture

 (One low-order digits of calendar year)

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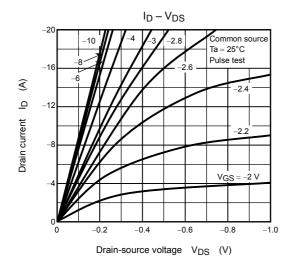
Electrical Characteristics (Ta = 25°C)

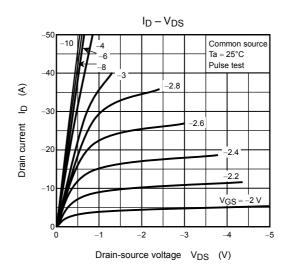
| Cha | aracteristics | Symbol | Test Condition | Min | Тур. | Max | Unit | |
|--|----------------|-----------------------|---|------------------------|---------|------|------|--|
| Gate leakage cur | rent | I _{GSS} | $V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$ | _ | _ | ±10 | μΑ | |
| Drain cut-OFF cu | rrent | I _{DSS} | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ | _ | — — –10 | | μА | |
| Drain-source breakdown voltage | | V _{(BR) DSS} | $I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$ | -30 | _ | _ | V | |
| Diani-source brea | akdown voltage | V (BR) DSX | $I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$ | -15 — — -0.8 — -2.0 | | · | | |
| Gate threshold vo | oltage | V _{th} | $V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$ | -0.8 | _ | -2.0 | V | |
| Drain source ON | registance | _ | $V_{GS} = -4 \text{ V}, I_D = -5.5 \text{ A}$ | _ | 18.5 | 23 | mO | |
| Drain-source ON resistance | | R _{DS (ON)} | $V_{GS} = -10 \text{ V}, I_D = -5.5 \text{ A}$ | _ | 9.5 | 13 | mΩ | |
| Forward transfer | admittance | Y _{fs} | $V_{DS} = -10 \text{ V}, I_D = -5.5 \text{ A}$ | . 12 24 — | | _ | S | |
| Input capacitance | | C _{iss} | V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz | _ | 3510 | _ | pF | |
| Reverse transfer capacitance | | C _{rss} | | _ | 250 | _ | | |
| Output capacitance | | C _{oss} | | _ | 600 | _ | | |
| Rise | Rise time | t _r | 0 V 7 F ln = -5.5 A | _ | 7 | _ | | |
| Switching time | Turn-ON time | t _{on} | $V_{GS} = 0 \text{ V}$ $V_{GS} = 0 \text{ V}$ $V_{GS} = 0 \text{ V}$ $V_{OUT} = 0 \text{ C}$ | _ | 16 | _ | 20 | |
| Switching time | Fall time | t _f | 4.7.0 4.0 4.0 4.0 4.0 4.0 4.0 4.0 4 | _ | 66 | _ | ns | |
| | Turn-OFF time | t _{off} | $V_{DD} \simeq -15 \text{ V}$ Duty \leq 1%, $t_W = 10 \mu\text{s}$ | _ | 230 | _ | | |
| Total gate charge (gate-source plus gate-drain) | | Qg | $V_{DD} \simeq -24 \text{ V}, V_{GS} = -10 \text{ V},$ $I_{D} = -11 \text{ A}$ | | 77 | | nC | |
| Gate-source charge 1 | | Q _{gs1} | | _ | 7.0 | _ | | |
| Gate-drain ("miller") charge | | Q _{gd} | | | 20 | _ | | |

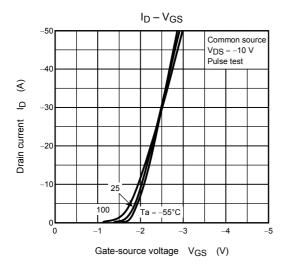
Source-Drain Ratings and Characteristics (Ta = 25°C)

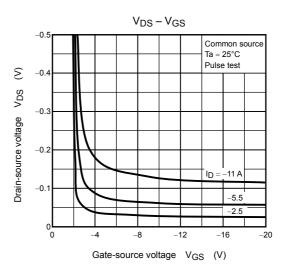
| Characteri | stics | | Symbol | Test Condition | Min | Тур. | Max | Unit |
|-------------------------|-------|----------|------------------|--|-----|------|-----|------|
| Drain reverse current | Pulse | (Note 1) | I _{DRP} | _ | _ | _ | -44 | Α |
| Forward voltage (diode) | | | V_{DSF} | $I_{DR} = -11 \text{ A}, V_{GS} = 0 \text{ V}$ | _ | _ | 1.2 | V |

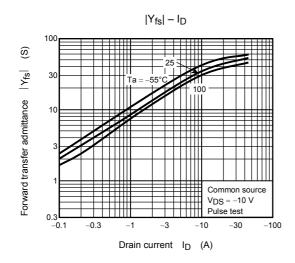
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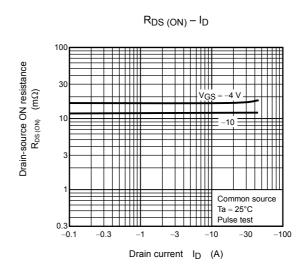


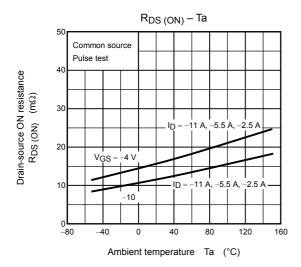


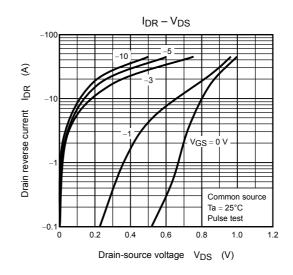


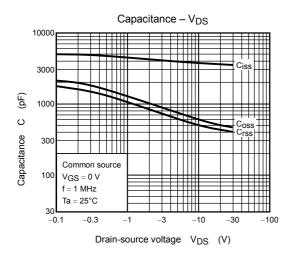


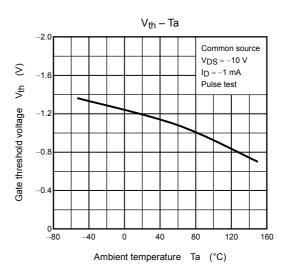


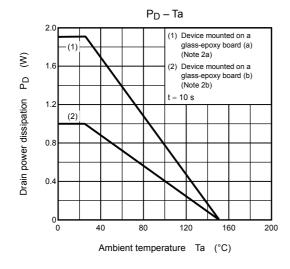


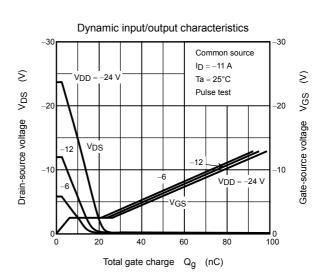


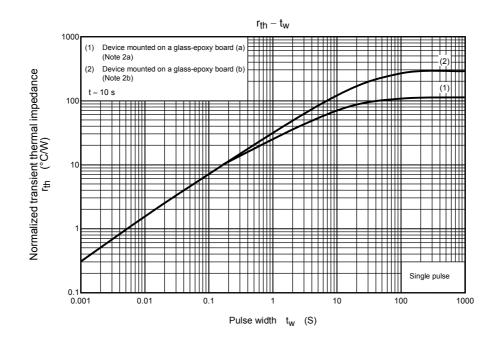


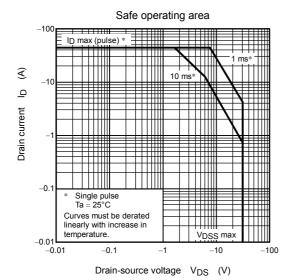












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